

Notice of References Cited

Application/Control N

10/038,990

Applicant(s)/Patent Under
Reexamination
JOO ET AL.

Examiner

Thao X Le

Art Unit

2814

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2001/0034088	10-2001	Nakamura et al.	438/166
	B	US-6,326,248	12-2001	Ohtani et al.	438/151
	C	US-4,908,334	03-1990	Zuhr et al.	438/682
	D	US-6,297,080	10-2001	Lee et al.	438/151
	E	US-6,329,229	12-2001	Yamazaki et al.	438/166
	F	US-6,423,565	07-2002	Barth et al.	438/57
	G	US-6,156,645	12-2000	Geha et al.	438/648
	H	US-6,187,667	02-2001	Shan et al.	438/636
	I	US-5,580,468	12-1996	Fujikawa et al.	216/27
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.